CBC3.1 update

Ongoing and upcomming activities

- Supply voltage range tests over temperature
 - LDO PSRR vs dropout
 - LDO dropout vs temperature
 - Analog front-end performance vs temperature
- Data and stub delay measurements
- Test to verify performance at high (random) trigger rate
- SEU tests scheduled for Feb 25-26

VLDOI

- Manual specifies VDDD as 1.2V+-10%
- VLDOI not actually defined, but MR verified for 1.25+-0.05V

https://indico.cern.ch/event/613723/contributions/2474070/attachments/1417085/2170028/CBC3_status_Feb_2017.pdf

Simulated hybrid temperature distribution (by Andreas Mussgiller):

